

TLC2652, TLC2652A, TLC2652Y
Advanced LinCMOS™ PRECISION CHOPPER-STABILIZED
OPERATIONAL AMPLIFIERS

SLOS019E – SEPTEMBER 1988 – REVISED FEBRUARY 2005

- Extremely Low Offset Voltage . . . 1 μ V Max
- Extremely Low Change on Offset Voltage With Temperature . . . 0.003 μ V/ $^{\circ}$ C Typ
- Low Input Offset Current
500 pA Max at $T_A = -55^{\circ}\text{C}$ to 125°C
- A_{VD} . . . 135 dB Min
- CMRR . . . 120 dB Min
- k_{SVR} . . . 110 dB Min
- Single-Supply Operation
- Common-Mode Input Voltage Range Includes the Negative Rail
- No Noise Degradation With External Capacitors Connected to $V_{\text{DD}-}$

description

The TLC2652 and TLC2652A are high-precision chopper-stabilized operational amplifiers using Texas Instruments Advanced LinCMOS™ process. This process, in conjunction with unique chopper-stabilization circuitry, produces operational amplifiers whose performance matches or exceeds that of similar devices available today.

Chopper-stabilization techniques make possible extremely high dc precision by continuously nulling input offset voltage even during variations in temperature, time, common-mode voltage, and power supply voltage. In addition, low-frequency noise voltage is significantly reduced. This high precision, coupled with the extremely high input impedance of the CMOS input stage, makes the TLC2652 and TLC2652A an ideal choice for low-level signal processing applications such as strain gauges, thermocouples, and other transducer amplifiers. For applications that require extremely low noise and higher usable bandwidth, use the TLC2654 or TLC2654A device, which has a chopping frequency of 10 kHz.

The TLC2652 and TLC2652A input common-mode range includes the negative rail, thereby providing superior performance in either single-supply or split-supply applications, even at power supply voltage levels as low as ± 1.9 V.

Two external capacitors are required for operation of the device; however, the on-chip chopper-control circuitry is transparent to the user. On devices in the 14-pin and 20-pin packages, the control circuitry is made accessible to allow the user the option of controlling the clock frequency with an external frequency source. In addition, the clock threshold level of the TLC2652 and TLC2652A requires no level shifting when used in the single-supply configuration with a normal CMOS or TTL clock input.

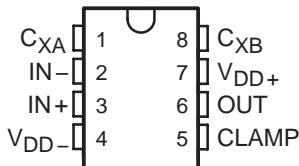


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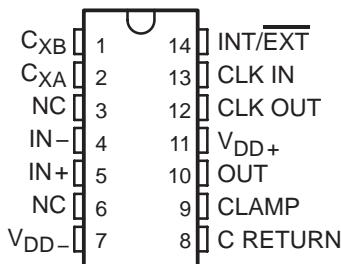
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PRODUCTION DATA information is current as of publication date.
Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

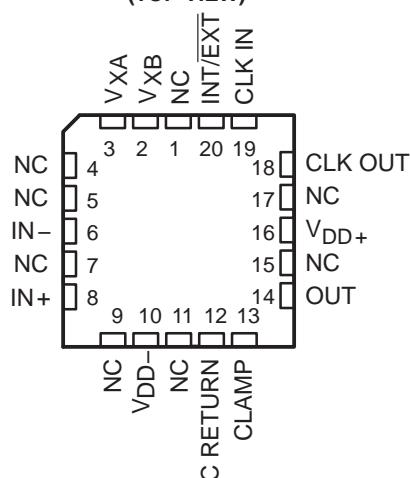
D008, JG, OR P PACKAGE
(TOP VIEW)



D014, J, OR N PACKAGE
(TOP VIEW)



FK PACKAGE
(TOP VIEW)



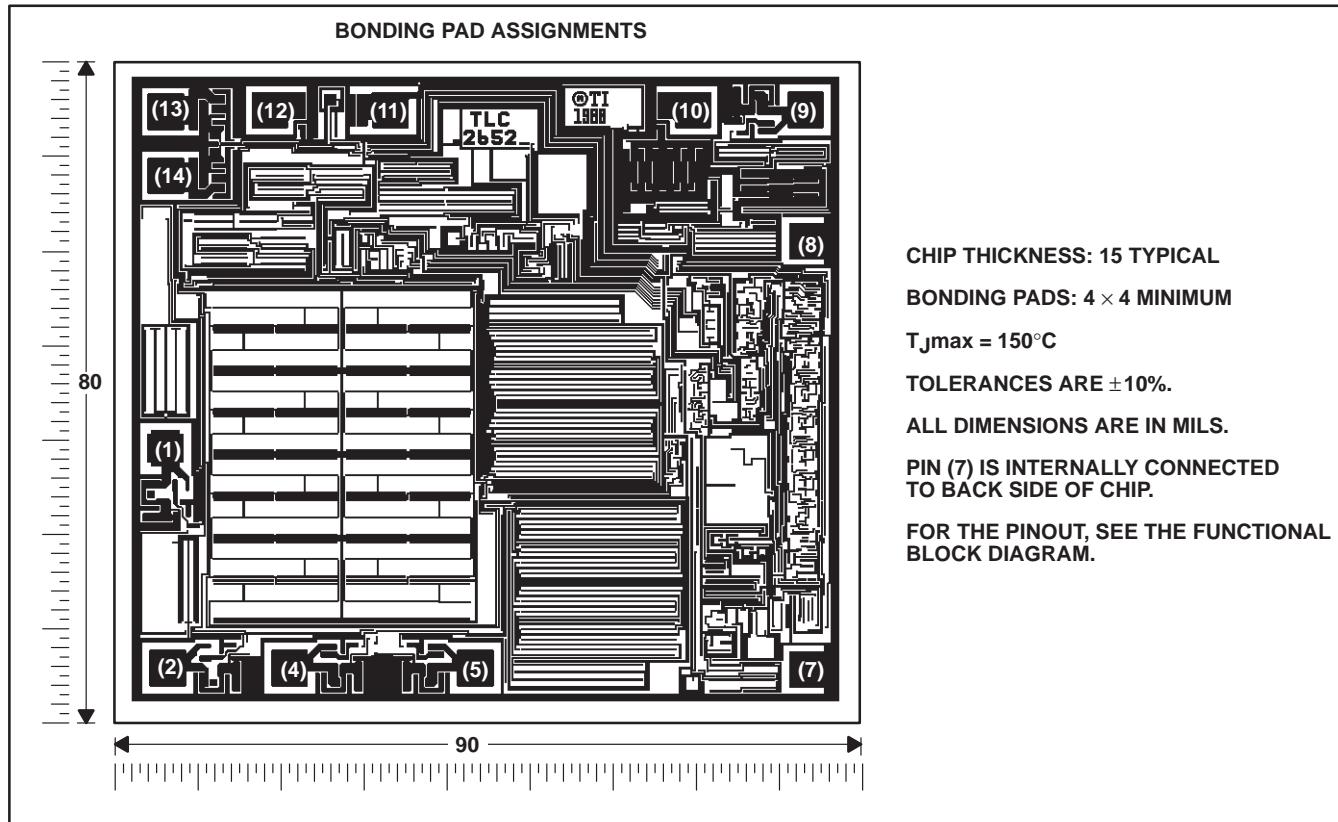
NC – No internal connection

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TLC2652Y chip information

This chip, when properly assembled, displays characteristics similar to the TLC2652C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



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operating characteristics specified free-air temperature, $V_{DD\pm} = \pm 5$ V

PARAMETER	TEST CONDITIONS	TA†	TLC2652C			TLC2652AC			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR+ Positive slew rate at unity gain	$V_O = \pm 2.3$ V, $R_L = 10$ kΩ, $C_L = 100$ pF	25°C	2	2.8		2	2.8		V/μs
		Full range	1.5			1.5			
SR- Negative slew rate at unity gain	$V_O = \pm 2.3$ V, $R_L = 10$ kΩ, $C_L = 100$ pF	25°C	2.3	3.1		2.3	3.1		V/μs
		Full range	1.8			1.8			
V_n Equivalent input noise voltage (see Note 6)	$f = 10$ Hz	25°C	94			94	140		nV/√Hz
		$f = 1$ kHz	25°C	23		23	35		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0$ to 1 Hz	25°C	0.8			0.8			μV
	$f = 0$ to 10 Hz	25°C	2.8			2.8			
I_n Equivalent input noise current	$f = 10$ kHz	25°C	0.004			0.004			fA/√Hz
Gain-bandwidth product	$f = 10$ kHz, $R_L = 10$ kΩ, $C_L = 100$ pF	25°C	1.9			1.9			MHz
ϕ_m Phase margin at unity gain	$R_L = 10$ kΩ, $C_L = 100$ pF	25°C	48°			48°			

† Full range is 0° to 70°C.

NOTE 6: This parameter is tested on a sample basis for the TLC2652A. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.



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operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5$ V

PARAMETER	TEST CONDITIONS	TA†	TLC2652I			TLC2652AI			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
SR+ Positive slew rate at unity gain	$V_O = \pm 2.3$ V, $R_L = 10$ kΩ, $C_L = 100$ pF	25°C	2	2.8		2	2.8		V/μs
		Full range	1.4			1.4			
SR- Negative slew rate at unity gain	$V_O = \pm 2.3$ V, $R_L = 10$ kΩ, $C_L = 100$ pF	25°C	2.3	3.1		2.3	3.1		V/μs
		Full range	1.7			1.7			
V_n Equivalent input noise voltage (see Note 6)	$f = 10$ Hz	25°C	94			94	140		nV/√Hz
		$f = 1$ kHz	25°C	23		23	35		
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	$f = 0$ to 1 Hz	25°C	0.8			0.8			μV
	$f = 0$ to 10 Hz	25°C	2.8			2.8			
I_n Equivalent input noise current	$f = 1$ kHz	25°C	0.004			0.004			pA/√Hz
Gain-bandwidth product	$f = 10$ kHz, $R_L = 10$ kΩ, $C_L = 100$ pF	25°C	1.9			1.9			MHz
ϕ_m Phase margin at unity gain	$R_L = 10$ kΩ, $C_L = 100$ pF	25°C	48°			48°			

† Full range is –40° to 85°C.

NOTE 6: This parameter is tested on a sample basis for the TLC2652A. For other test requirements, please contact the factory. This statement has no bearing on testing or nontesting of other parameters.



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operating characteristics at specified free-air temperature, $V_{DD\pm} = \pm 5$ V

PARAMETER	TEST CONDITIONS	T_A^\dagger	TLC2652Q			UNIT
			MIN	TYP	MAX	
SR + Positive slew rate at unity gain	$V_O = \pm 2.3$ V, $R_L = 10$ k Ω , $C_L = 100$ pF	25°C	2	2.8		V/ μ s
		Full range	1.3			
SR - Negative slew rate at unity gain	$V_O = \pm 2.3$ V, $R_L = 10$ k Ω , $C_L = 100$ pF	25°C	2.3	3.1		V/ μ s
		Full range	1.6			
V_n Equivalent input noise voltage	f = 10 Hz	25°C	94			nV/ $\sqrt{\text{Hz}}$
	f = 1 kHz	25°C	23			
$V_{N(PP)}$ Peak-to-peak equivalent input noise voltage	f = 0 to 1 Hz	25°C	0.8			μ V
	f = 0 to 10 Hz	25°C	2.8			
I_n Equivalent input noise current	f = 1 kHz	25°C	0.004			pA/ $\sqrt{\text{Hz}}$
	Gain-bandwidth product	$f = 10$ kHz, $R_L = 10$ k Ω , $C_L = 100$ pF	25°C	1.9		
ϕ_m Phase margin at unity gain	$R_L = 10$ k Ω , $C_L = 100$ pF	25°C	48°			

† Full range is –40° to 125°C for the Q suffix, –55° to 125°C for the M suffix.

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electrical characteristics at $V_{DD\pm} = \pm 5$ V, $T_A = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	TLC2652Y			UNIT
		MIN	TYP	MAX	
V_{IO}	$V_{IC} = 0$, $R_S = 50\ \Omega$		0.6	3	μV
Input offset voltage long-term drift (see Note 4)			0.003	0.006	$\mu\text{V}/\text{mo}$
I_{IO}			2	60	pA
I_{IB}			4	60	pA
V_{ICR}	$R_S = 50\ \Omega$		–5 to 3.1		V
Common-mode input voltage range			–5	4.8	
V_{OM+}	$R_L = 10\ \text{k}\Omega$, See Note 5	4.7	4.8		V
V_{OM-}	$R_L = 10\ \text{k}\Omega$, See Note 5	–4.7	–4.9		V
AVD	$V_O = \pm 4$ V, $R_L = 10\ \text{k}\Omega$	120	150		dB
f_{ch}			450		Hz
Clamp on-state current	$R_L = 100\ \text{k}\Omega$		25		μA
Clamp off-state current	$V_O = –4$ V to 4 V		100		pA
CMRR	$V_O = 0$, $V_{IC} = V_{ICR\min}$, $R_S = 50\ \Omega$	120	140		dB
k_{SVR}	$V_{DD\pm} = \pm 1.9$ V to ± 8 V, $R_S = 50\ \Omega$ $V_O = 0$,	110	135		dB
I_{DD}	$V_O = 0$, No load	1.5	2.4		mA

NOTES: 4. Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^\circ\text{C}$ extrapolated at $T_A = 25^\circ$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.
5. Output clamp is not connected.

operating characteristics at $V_{DD\pm} = \pm 5$ V, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TLC2652Y			UNIT
		MIN	TYP	MAX	
SR_+	$V_O = \pm 2.3$ V, $R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$	2	2.8		$\text{V}/\mu\text{s}$
SR_-		2.3	3.1		$\text{V}/\mu\text{s}$
V_n	$f = 10\ \text{Hz}$		94		$\text{nV}/\sqrt{\text{Hz}}$
	$f = 1\ \text{kHz}$		23		
$V_{N(PP)}$	$f = 0$ to 1 Hz		0.8		μV
	$f = 0$ to 10 Hz		2.8		
I_n	$f = 1\ \text{kHz}$				$\text{pA}/\sqrt{\text{Hz}}$
Gain-bandwidth product	$f = 10\ \text{kHz}$, $R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$		1.9		MHz
ϕ_m	$R_L = 10\ \text{k}\Omega$, $C_L = 100\ \text{pF}$		48°		

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TYPICAL CHARACTERISTICS

Table of Graphs

		FIGURE	
V_{IO}	Normalized input offset voltage	vs Chopping frequency	1
I_{IB}	Input bias current	vs Common-mode input voltage vs Chopping frequency vs Free-air temperature	2 3 4
I_{IO}	Input offset current	vs Chopping frequency vs Free-air temperature	5 6
	Clamp current	vs Output voltage	7
$V_{(OPP)}$	Maximum peak-to-peak output voltage	vs Frequency	8
V_{OM}	Maximum peak output voltage	vs Output current vs Free-air temperature	9, 10 11, 12
AVD	Large-signal differential voltage amplification	vs Frequency vs Free-air temperature	13 14
	Chopping frequency	vs Supply voltage vs Free-air temperature	15 16
I_{DD}	Supply current	vs Supply voltage vs Free-air temperature	17 18
I_{OS}	Short-circuit output current	vs Supply voltage vs Free-air temperature	19 20
SR	Slew rate	vs Supply voltage vs Free-air temperature	21 22
	Voltage-follower pulse response	Small-signal Large-signal	23 24
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	vs Chopping frequency	25, 26
V_n	Equivalent input noise voltage	vs Frequency	27
	Gain-bandwidth product	vs Supply voltage vs Free-air temperature	28 29
ϕ_m	Phase margin	vs Supply voltage vs Free-air temperature vs Load capacitance	30 31 32
	Phase shift	vs Frequency	13

TYPICAL CHARACTERISTICS[†]

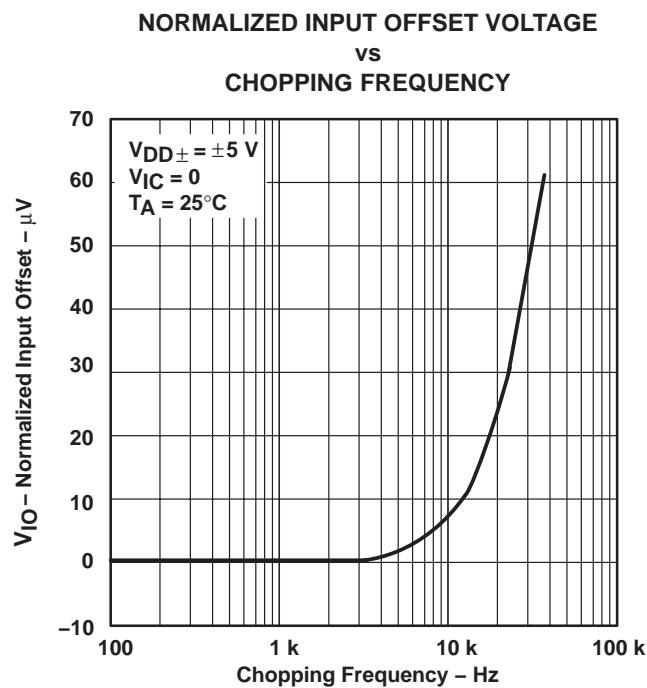


Figure 1

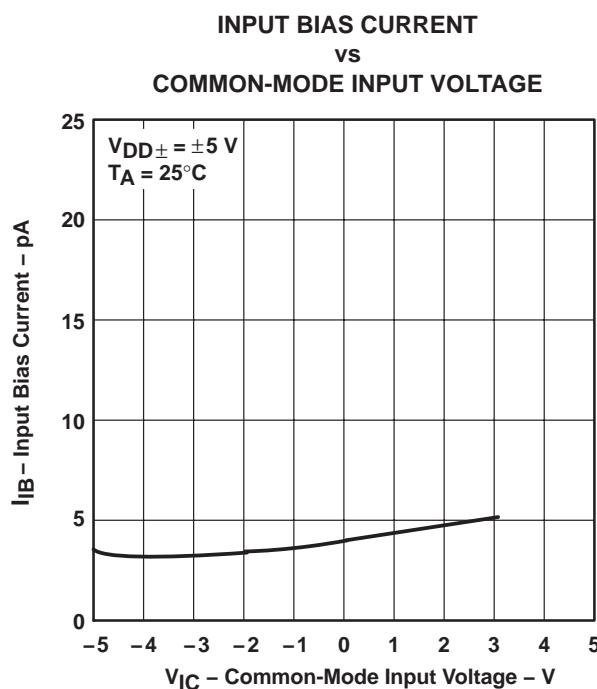


Figure 2

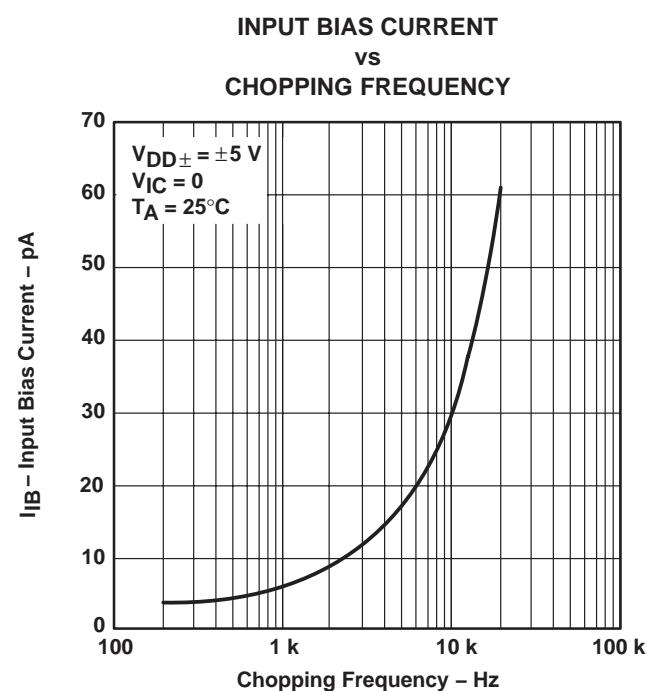


Figure 3

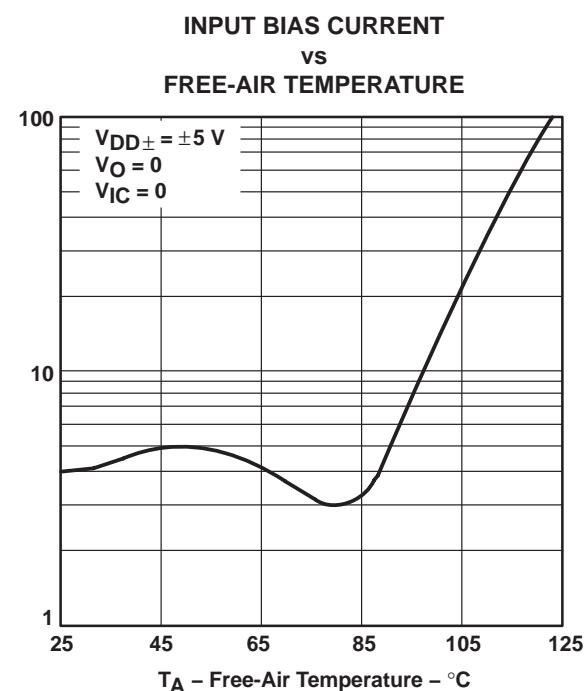


Figure 4

[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS†

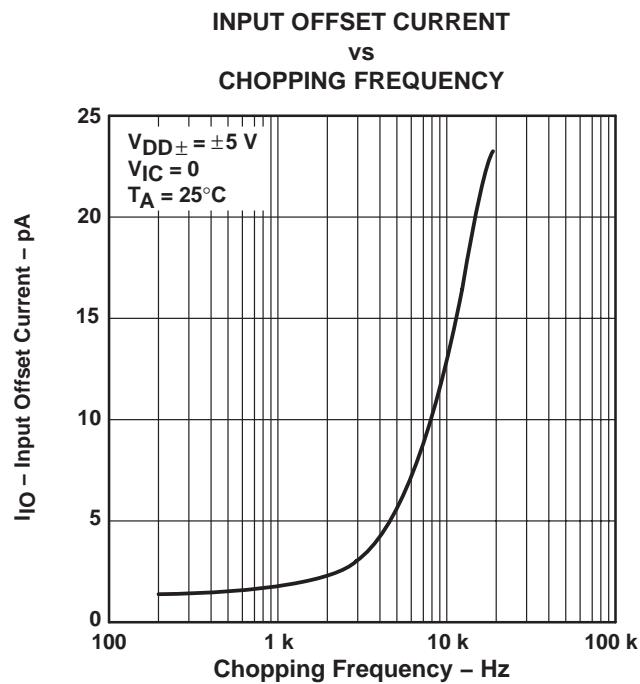


Figure 5

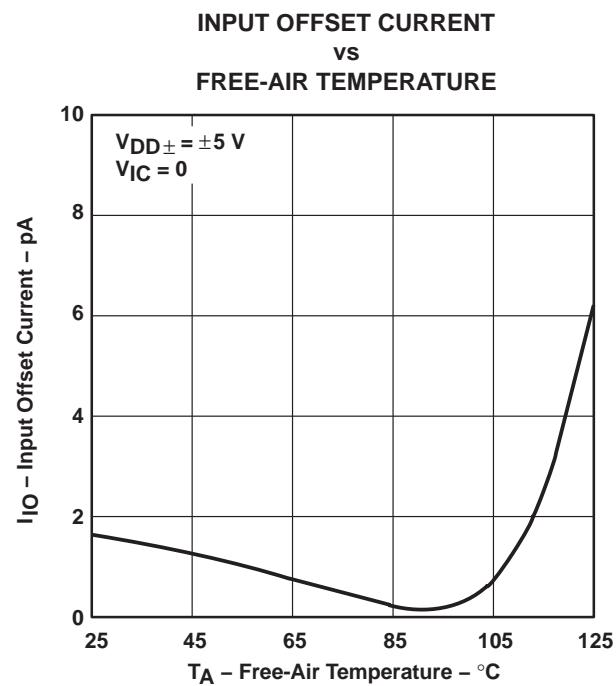


Figure 6

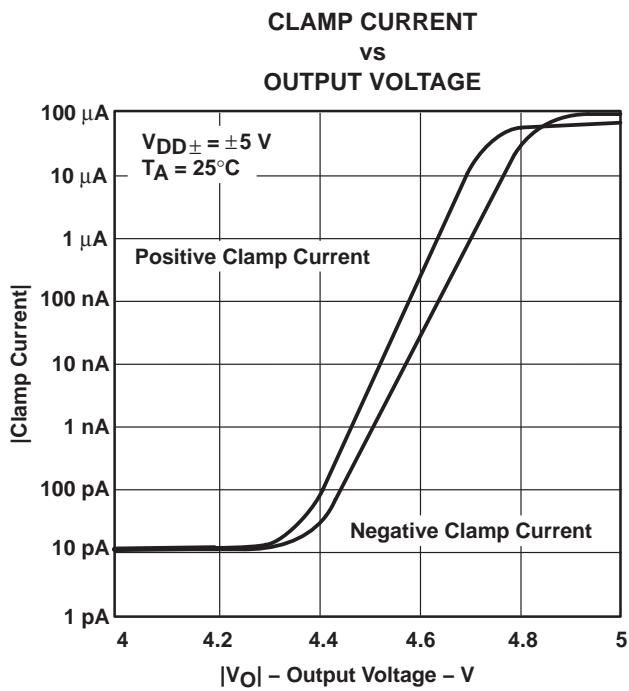


Figure 7

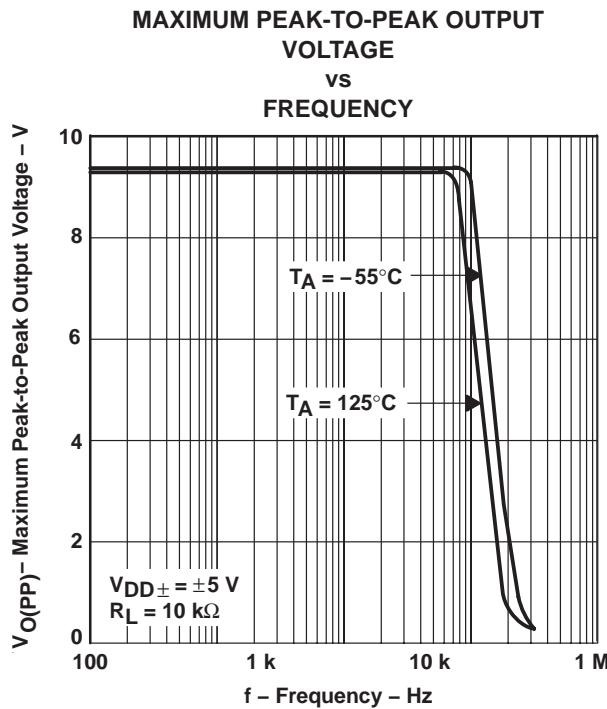


Figure 8

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS[†]

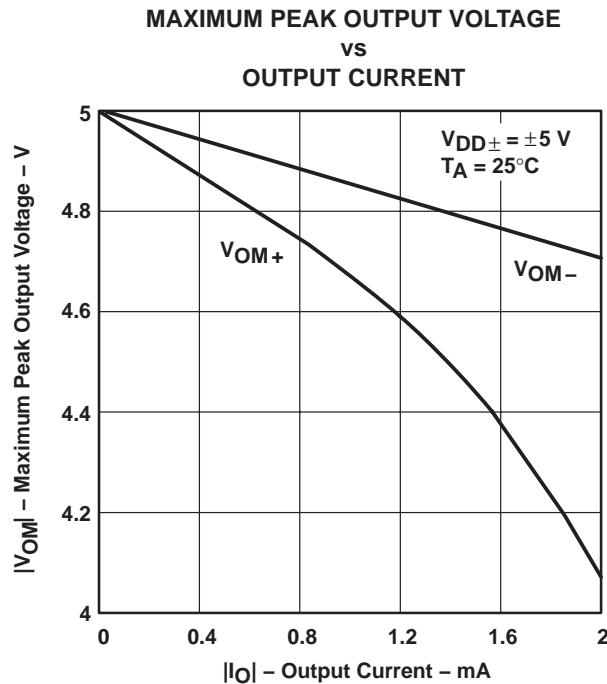


Figure 9

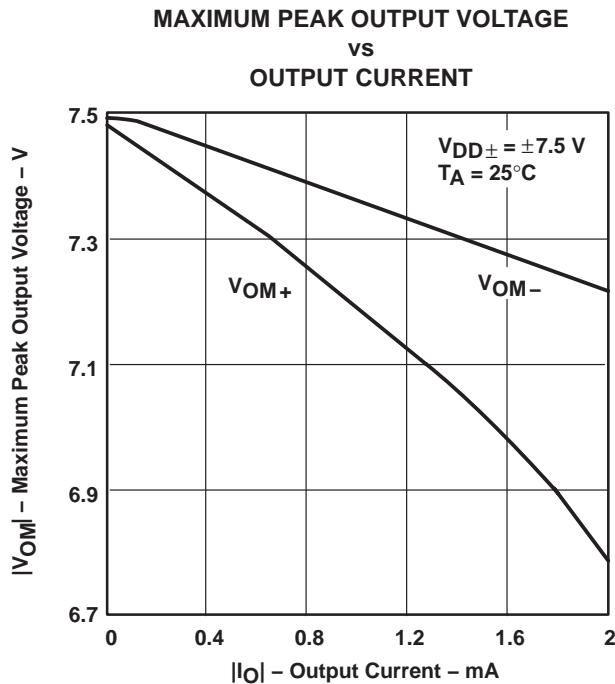


Figure 10

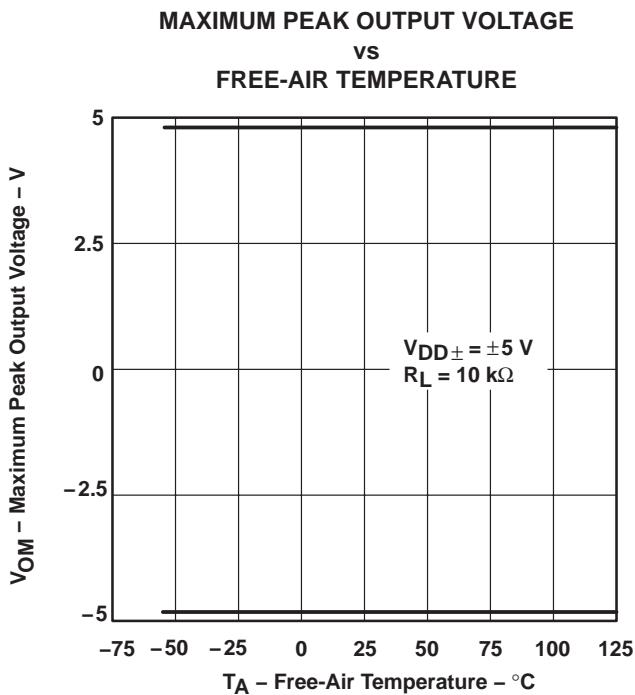


Figure 11

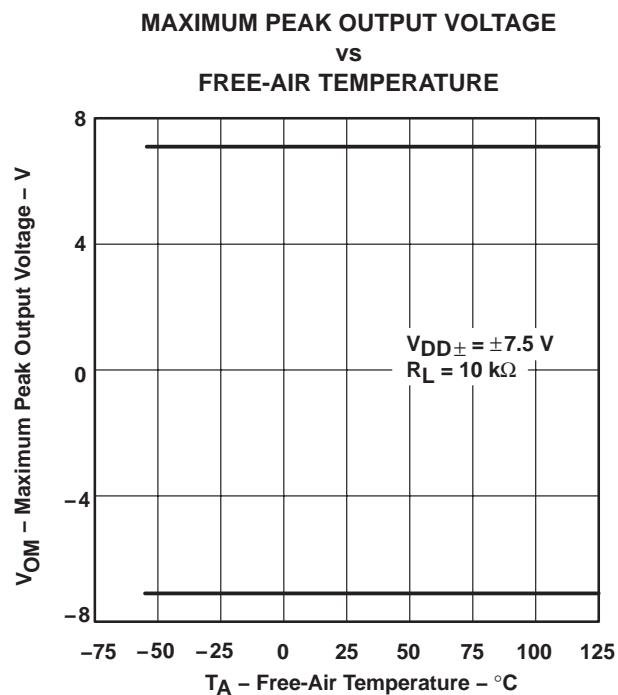


Figure 12

[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS†

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
AMPLIFICATION AND PHASE SHIFT
VS
FREQUENCY

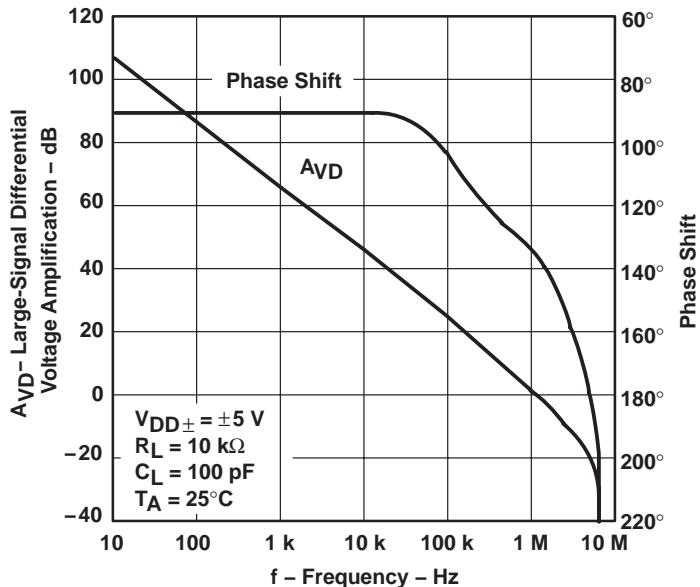


Figure 13

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
AMPLIFICATION
VS
FREE-AIR TEMPERATURE

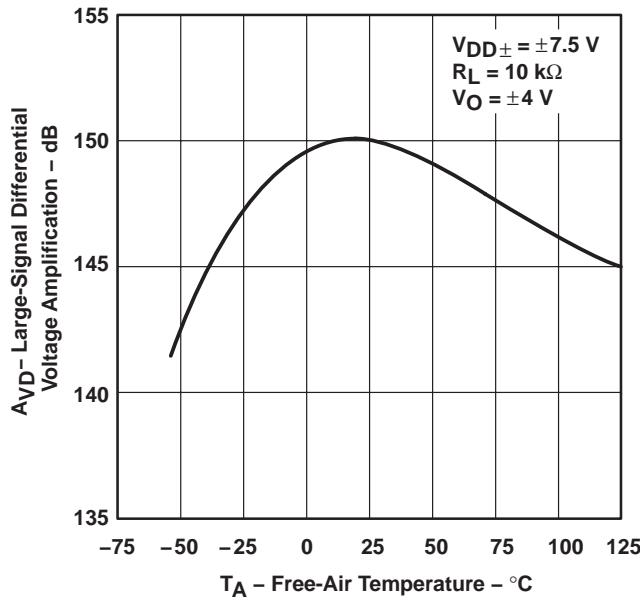


Figure 14

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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TYPICAL CHARACTERISTICS[†]

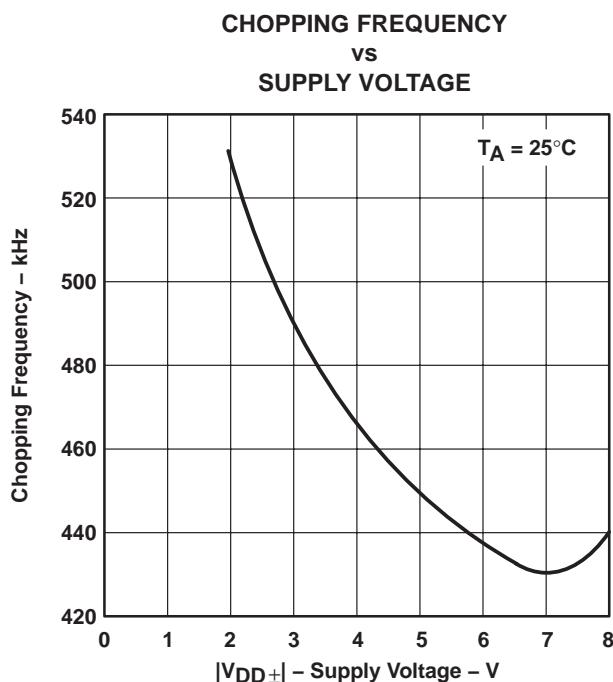


Figure 15

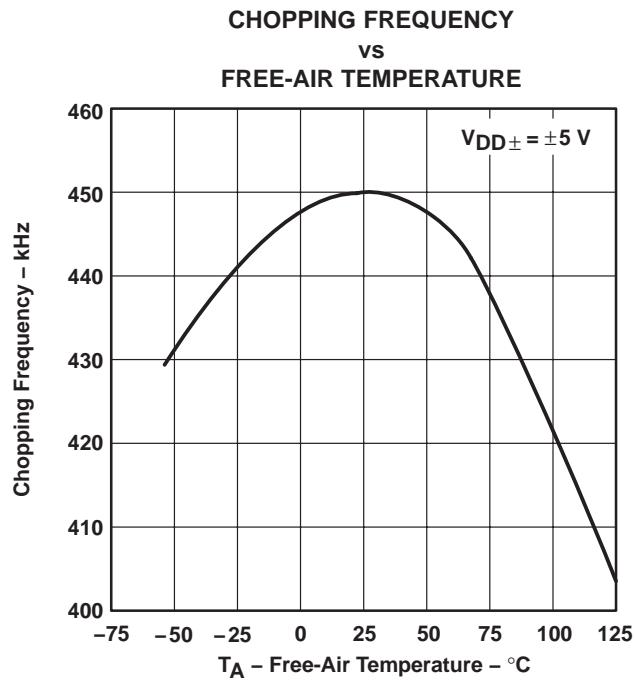


Figure 16

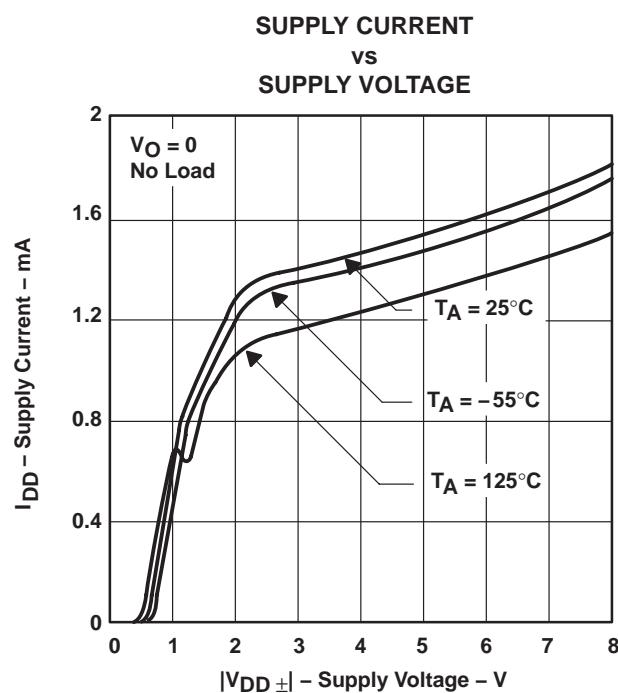


Figure 17

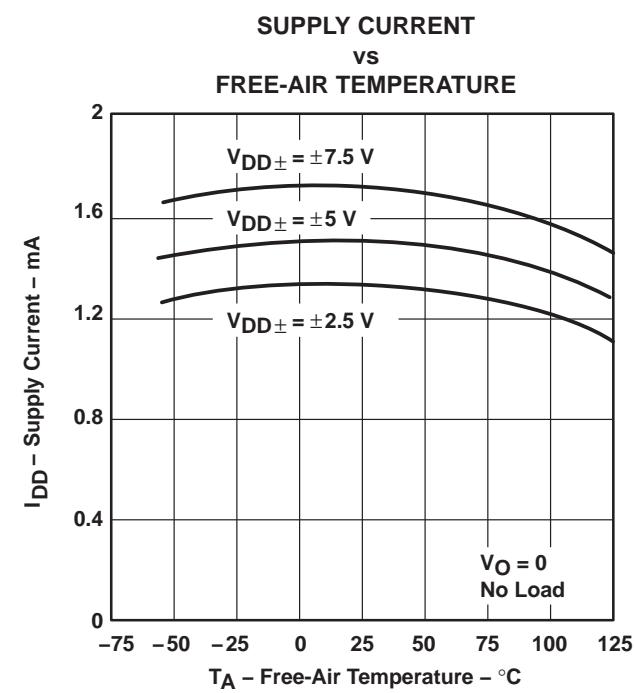


Figure 18

[†]Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS†

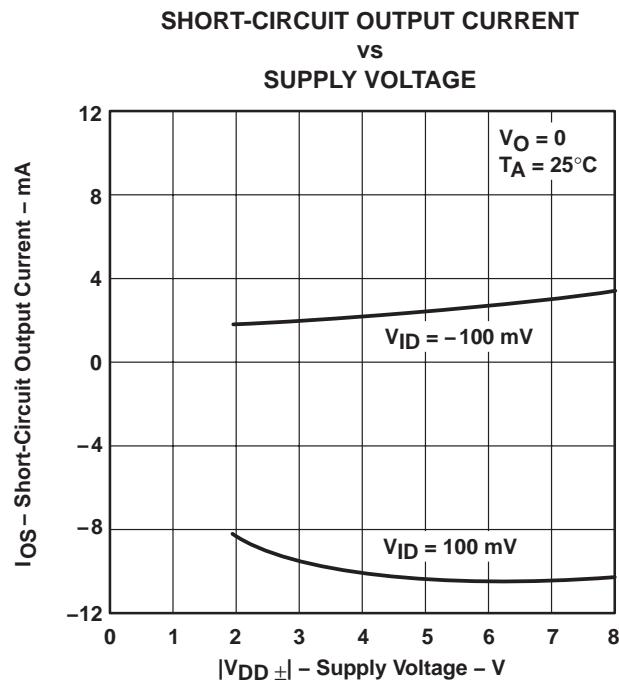


Figure 19

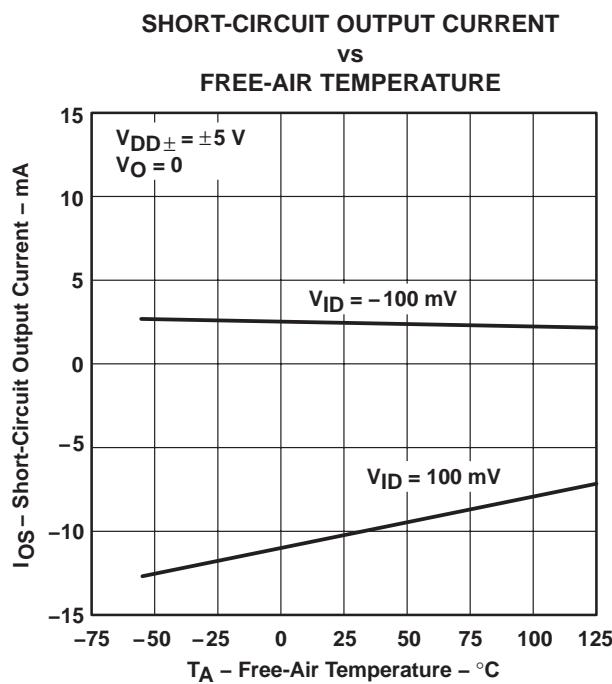


Figure 20

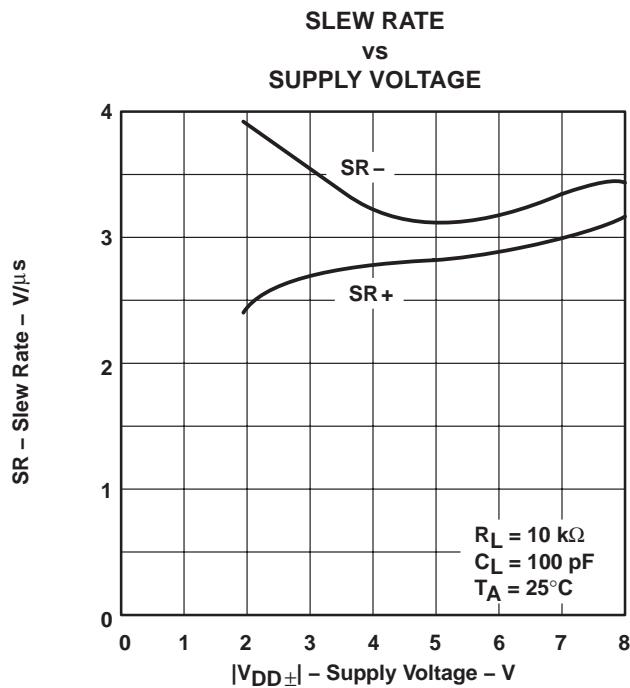


Figure 21

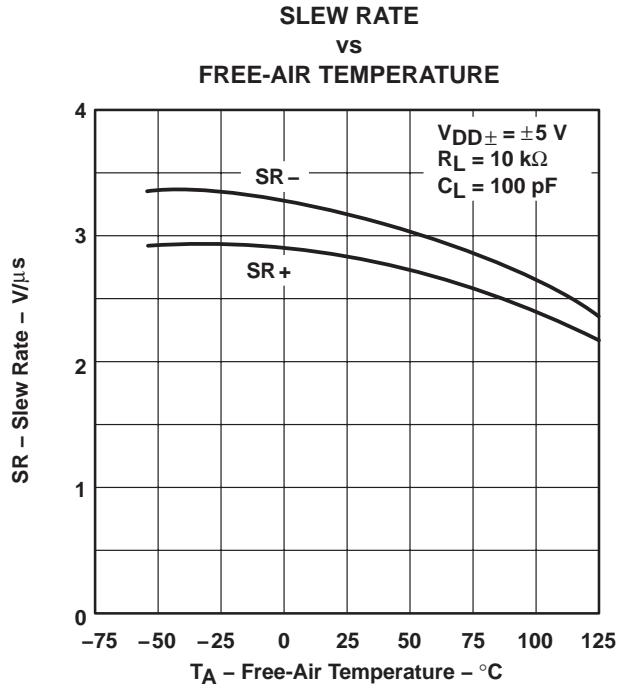


Figure 22

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

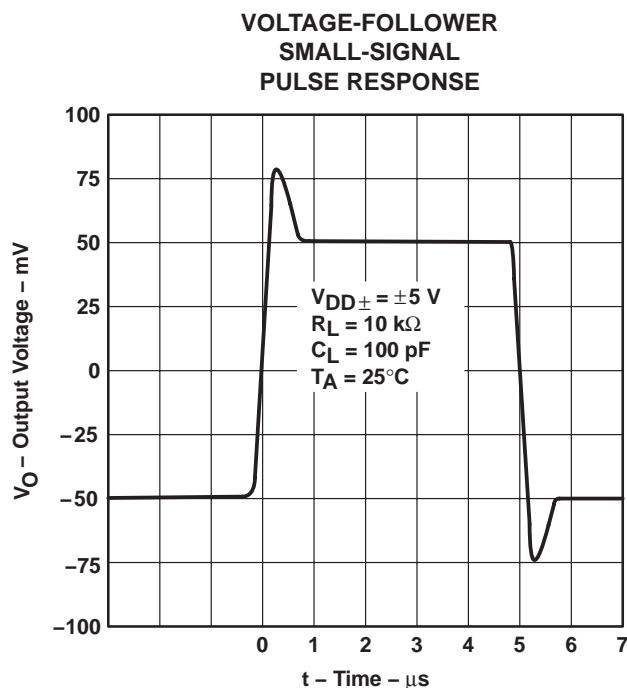


Figure 23

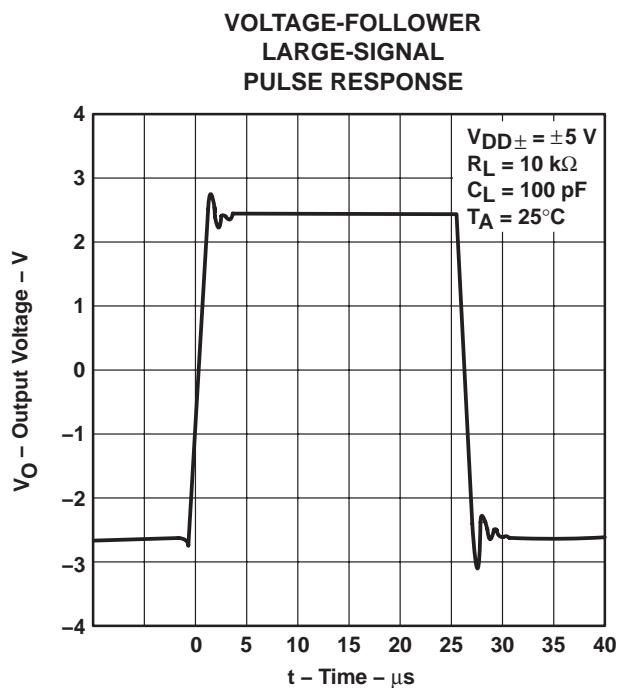


Figure 24

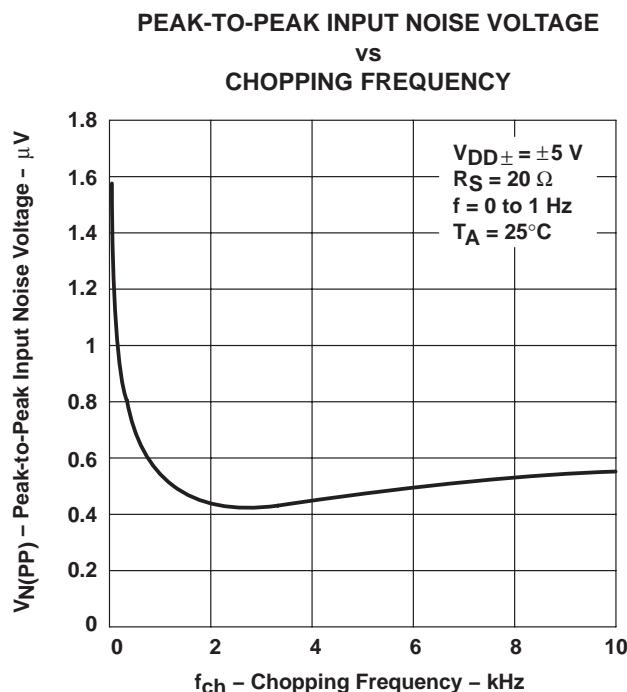


Figure 25

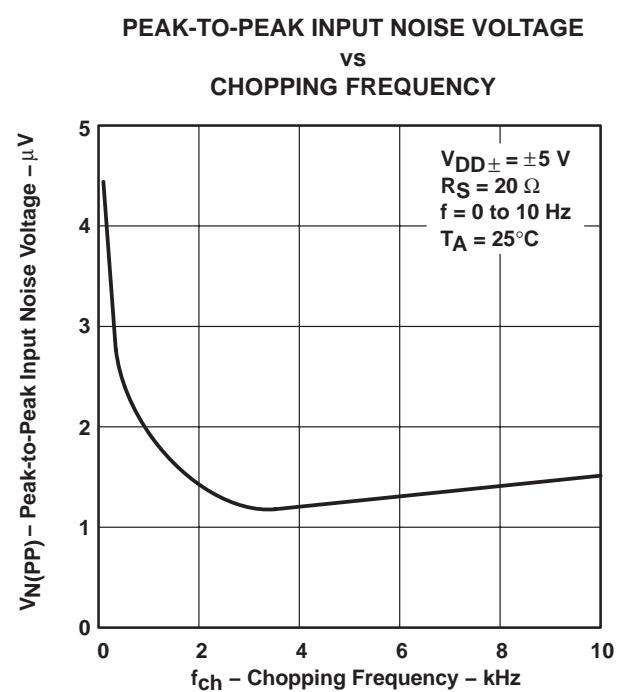


Figure 26

TYPICAL CHARACTERISTICS†

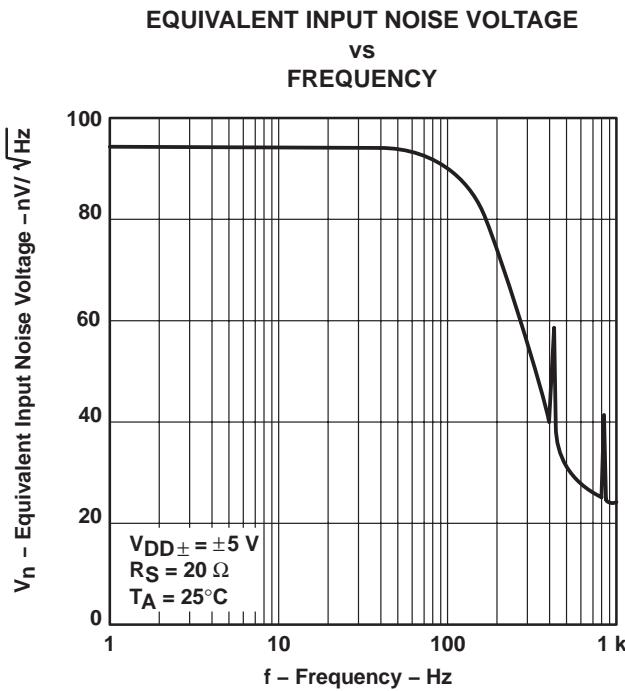


Figure 27

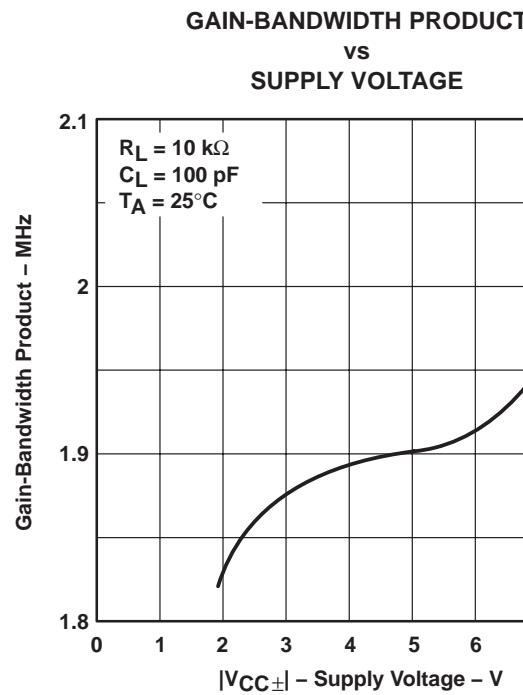


Figure 28

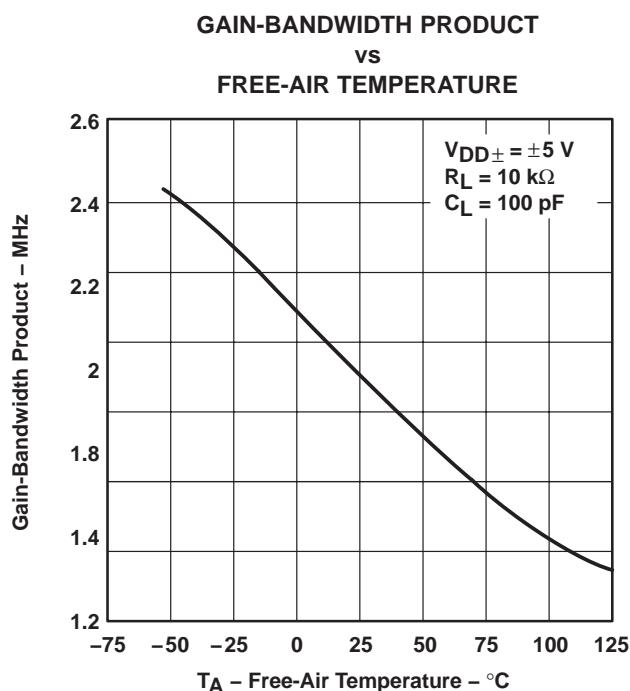


Figure 29

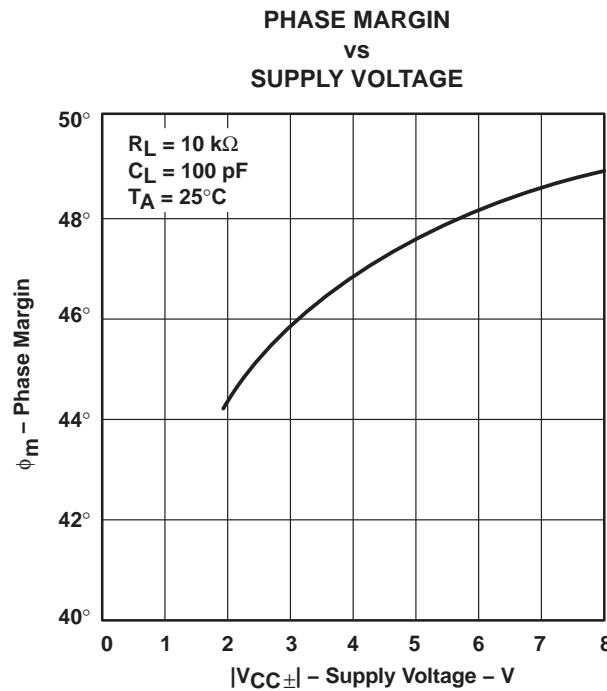


Figure 30

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS^T

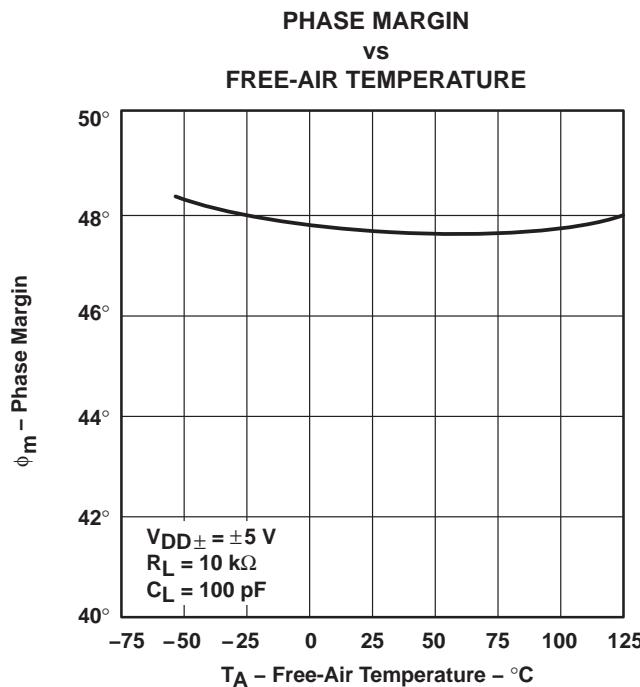


Figure 31

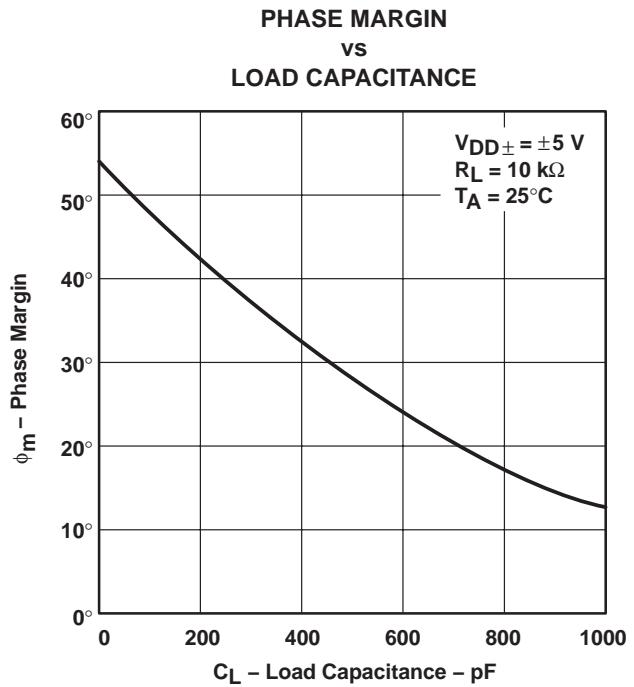


Figure 32

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

APPLICATION INFORMATION

capacitor selection and placement

The two important factors to consider when selecting external capacitors C_{XA} and C_{XB} are leakage and dielectric absorption. Both factors can cause system degradation, negating the performance advantages realized by using the TLC2652.

Degradation from capacitor leakage becomes more apparent with the increasing temperatures. Low-leakage capacitors and standoffs are recommended for operation at $T_A = 125^\circ\text{C}$. In addition, guard bands are recommended around the capacitor connections on both sides of the printed circuit board to alleviate problems caused by surface leakage on circuit boards.

Capacitors with high dielectric absorption tend to take several seconds to settle upon application of power, which directly affects input offset voltage. In applications where fast settling of input offset voltage is needed, it is recommended that high-quality film capacitors, such as mylar, polystyrene, or polypropylene, be used. In other applications, however, a ceramic or other low-grade capacitor can suffice.

Unlike many choppers available today, the TLC2652 is designed to function with values of C_{XA} and C_{XB} in the range of 0.1 μF to 1 μF without degradation to input offset voltage or input noise voltage. These capacitors should be located as close as possible to the C_{XA} and C_{XB} pins and returned to either V_{DD-} or C RETURN. On many choppers, connecting these capacitors to V_{DD-} causes degradation in noise performance. This problem is eliminated on the TLC2652.

APPLICATION INFORMATION**internal/external clock**

The TLC2652 has an internal clock that sets the chopping frequency to a nominal value of 450 Hz. On 8-pin packages, the chopping frequency can only be controlled by the internal clock; however, on all 14-pin packages and the 20-pin FK package, the device chopping frequency can be set by the internal clock or controlled externally by use of the INT/EXT and CLK IN pins. To use the internal 450-Hz clock, no connection is necessary. If external clocking is desired, connect INT/EXT to V_{DD_-} and the external clock to CLK IN. The external clock trip point is 2.5 V above the negative rail; however, CLK IN can be driven from the negative rail to 5 V above the negative rail. If this level is exceeded, damage could occur to the device unless the current into CLK IN is limited to ± 5 mA. When operating in the single-supply configuration, this feature allows the TLC2652 to be driven directly by 5-V TTL and CMOS logic. A divide-by-two frequency divider interfaces with CLK IN and sets the clock chopping frequency. The duty cycle of the external clock is not critical but should be kept between 30% and 60%.

overload recovery/output clamp

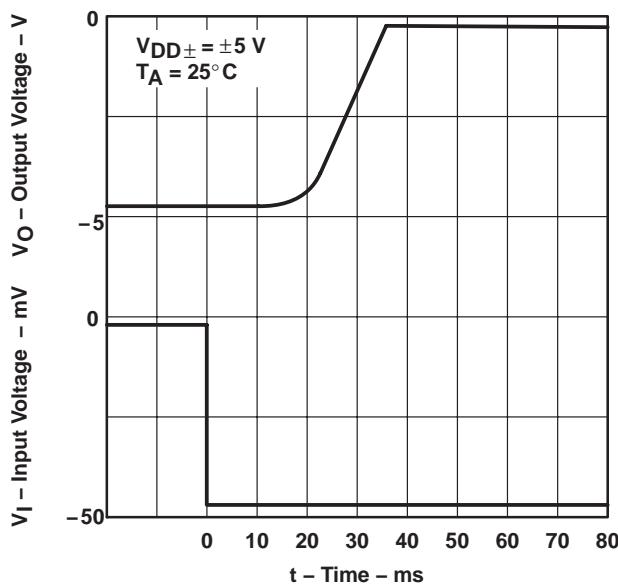
When large differential input voltage conditions are applied to the TLC2652, the nulling loop attempts to prevent the output from saturating by driving C_{XA} and C_{XB} to internally-clamped voltage levels. Once the overdrive condition is removed, a period of time is required to allow the built-up charge to dissipate. This time period is defined as overload recovery time (see Figure 33). Typical overload recovery time for the TLC2652 is significantly faster than competitive products; however, if required, this time can be reduced further by use of internal clamp circuitry accessible through CLAMP if required.

The clamp is a switch that is automatically activated when the output is approximately 1 V from either supply rail. When connected to the inverting input (in parallel with the closed-loop feedback resistor), the closed-loop gain is reduced, and the TLC2652 output is prevented from going into saturation. Since the output must source or sink current through the switch (see Figure 7), the maximum output voltage swing is slightly reduced.

thermoelectric effects

To take advantage of the extremely low offset voltage drift of the TLC2652, care must be taken to compensate for the thermoelectric effects present when two dissimilar metals are brought into contact with each other (such as device leads being soldered to a printed circuit board). Dissimilar metal junctions can produce thermoelectric voltages in the range of several microvolts per degree Celsius (orders of magnitude greater than the $0.01\text{-}\mu\text{V}/^\circ\text{C}$ typical of the TLC2652).

To help minimize thermoelectric effects, careful attention should be paid to component selection and circuit-board layout. Avoid the use of nonsoldered connections (such as sockets, relays, switches, etc.) in the input signal path. Cancel thermoelectric effects by duplicating the number of components and junctions in each device input. The use of low-thermoelectric-coefficient components, such as wire-wound resistors, is also beneficial.

**Figure 33. Overload Recovery**

APPLICATION INFORMATION

latch-up avoidance

Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLC2652 inputs and output are designed to withstand –100-mA surge currents without sustaining latch-up; however, techniques to reduce the chance of latch-up should be used whenever possible. Internal protection diodes should not, by design, be forward biased. Applied input and output voltages should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 μ F typical) located across the supply rails as close to the device as possible.

The current path established if latch-up occurs is usually between the supply rails and is limited only by the impedance of the power supply and the forward resistance of the parasitic thyristor. The chance of latch-up occurring increases with increasing temperature and supply voltage.

electrostatic discharge protection

The TLC2652 incorporates internal ESD-protection circuits that prevent functional failures at voltages at or below 2000 V. Care should be exercised in handling these devices, as exposure to ESD may result in degradation of the device parametric performance.

theory of operation

Chopper-stabilized operational amplifiers offer the best dc performance of any monolithic operational amplifier. This superior performance is the result of using two operational amplifiers, a main amplifier and a nulling amplifier, plus oscillator-controlled logic and two external capacitors to create a system that behaves as a single amplifier. With this approach, the TLC2652 achieves submicrovolt input offset voltage, submicrovolt noise voltage, and offset voltage variations with temperature in the nV/ $^{\circ}$ C range.

The TLC2652 on-chip control logic produces two dominant clock phases: a nulling phase and an amplifying phase. The term chopper-stabilized derives from the process of switching between these two clock phases. Figure 34 shows a simplified block diagram of the TLC2652. Switches A and B are make-before-break types.

During the nulling phase, switch A is closed shorting the nulling amplifier inputs together and allowing the nulling amplifier to reduce its own input offset voltage by feeding its output signal back to an inverting input node. Simultaneously, external capacitor C_{XA} stores the nulling potential to allow the offset voltage of the amplifier to remain nulled during the amplifying phase.

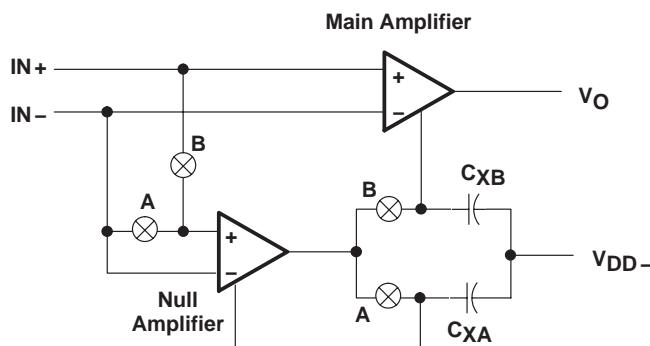


Figure 34. TLC2652 Simplified Block Diagram

APPLICATION INFORMATION**theory of operation (continued)**

During the amplifying phase, switch B is closed connecting the output of the nulling amplifier to a noninverting input of the main amplifier. In this configuration, the input offset voltage of the main amplifier is nulled. Also, external capacitor C_{XB} stores the nulling potential to allow the offset voltage of the main amplifier to remain nulled during the next nulling phase.

This continuous chopping process allows offset voltage nulling during variations in time and temperature over the common-mode input voltage range and power supply range. In addition, because the low-frequency signal path is through both the null and main amplifiers, extremely high gain is achieved.

The low-frequency noise of a chopper amplifier depends on the magnitude of the component noise prior to chopping and the capability of the circuit to reduce this noise while chopping. The use of the Advanced LinCMOS process, with its low-noise analog MOS transistors and patent-pending input stage design, significantly reduces the input noise voltage.

The primary source of nonideal operation in chopper-stabilized amplifiers is error charge from the switches. As charge imbalance accumulates on critical nodes, input offset voltage can increase, especially with increasing chopping frequency. This problem has been significantly reduced in the TLC2652 by use of a patent-pending compensation circuit and the Advanced LinCMOS process.

The TLC2652 incorporates a feed-forward design that ensures continuous frequency response. Essentially, the gain magnitude of the nulling amplifier and compensation network crosses unity at the break frequency of the main amplifier. As a result, the high-frequency response of the system is the same as the frequency response of the main amplifier. This approach also ensures that the slewing characteristics remain the same during both the nulling and amplifying phases.



PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9089501MPA	ACTIVE	CDIP	JG	8	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9089501MPA TLC2652M	Samples
5962-9089503MCA	ACTIVE	CDIP	J	14	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9089503MC A TLC2652AMJB	Samples
5962-9089503MPA	ACTIVE	CDIP	JG	8	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9089503MPA TLC2652AM	Samples
TLC2652AC-14D	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2652AC	Samples
TLC2652AC-8D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	2652AC	Samples
TLC2652ACN	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	TLC2652ACN	Samples
TLC2652ACP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	TLC2652AC	Samples
TLC2652AI-14D	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2652AI	Samples
TLC2652AI-8D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2652AI	Samples
TLC2652AI-8DR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	2652AI	Samples
TLC2652AIN	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	TLC2652AIN	Samples
TLC2652AIP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 85	TLC2652AI	Samples
TLC2652AMJB	ACTIVE	CDIP	J	14	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9089503MC A TLC2652AMJB	Samples
TLC2652AMJGB	ACTIVE	CDIP	JG	8	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9089503MPA TLC2652AM	Samples
TLC2652C-8D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2652C	Samples
TLC2652C-8DR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2652C	Samples
TLC2652CN	ACTIVE	PDIP	N	14	25	RoHS & Green	NIPDAU	N / A for Pkg Type		TLC2652CN	Samples
TLC2652CP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type		TLC2652CP	Samples

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TLC2652I-8D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2652I	Samples
TLC2652I-8DR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		2652I	Samples
TLC2652MJG	ACTIVE	CDIP	JG	8	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	TLC2652MJG	Samples
TLC2652MJGB	ACTIVE	CDIP	JG	8	1	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	9089501MPA TLC2652M	Samples
TLC2652Q-8D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	T2652Q	Samples
TLC2652Q-8DG4	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		T2652Q	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF TLC2652A, TLC2652AM :

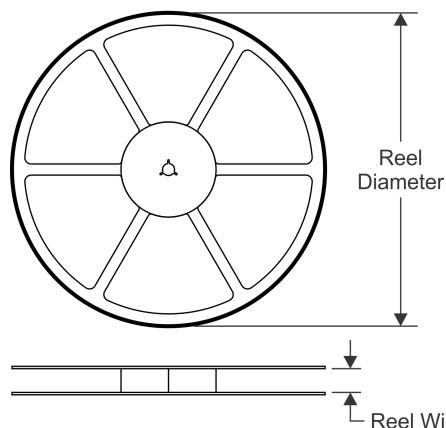
- Catalog : [TLC2652A](#)
- Military : [TLC2652AM](#)

NOTE: Qualified Version Definitions:

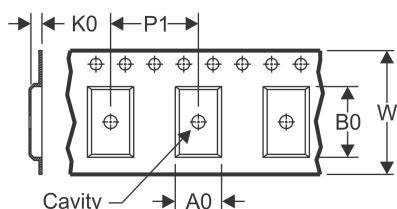
- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

TAPE AND REEL INFORMATION

REEL DIMENSIONS

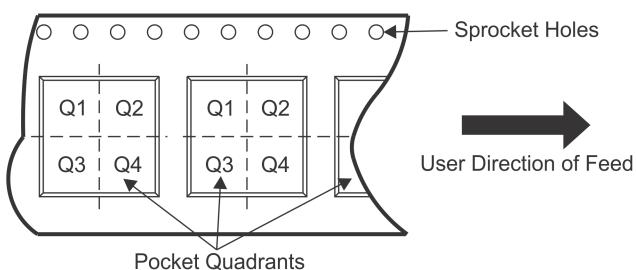


TAPE DIMENSIONS



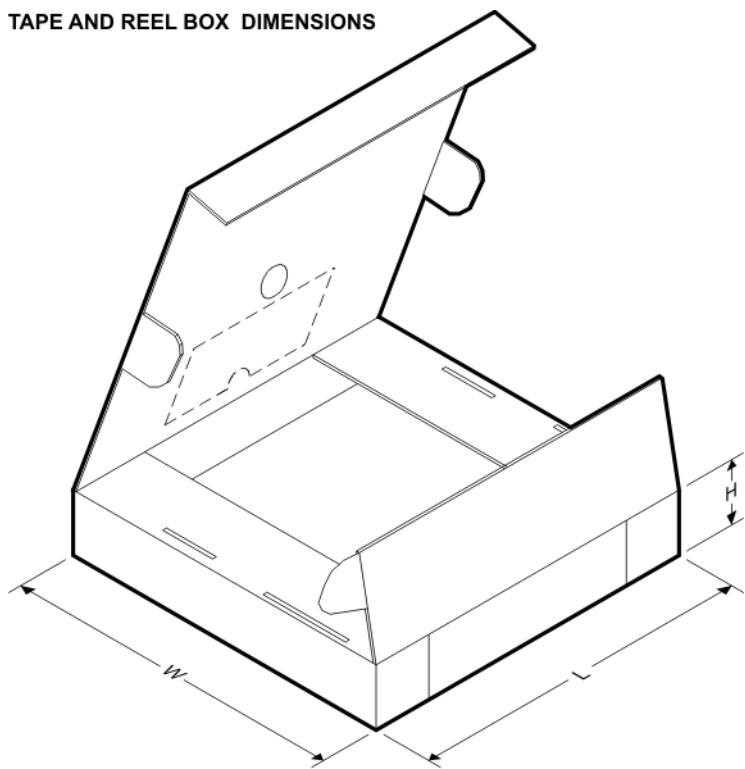
A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



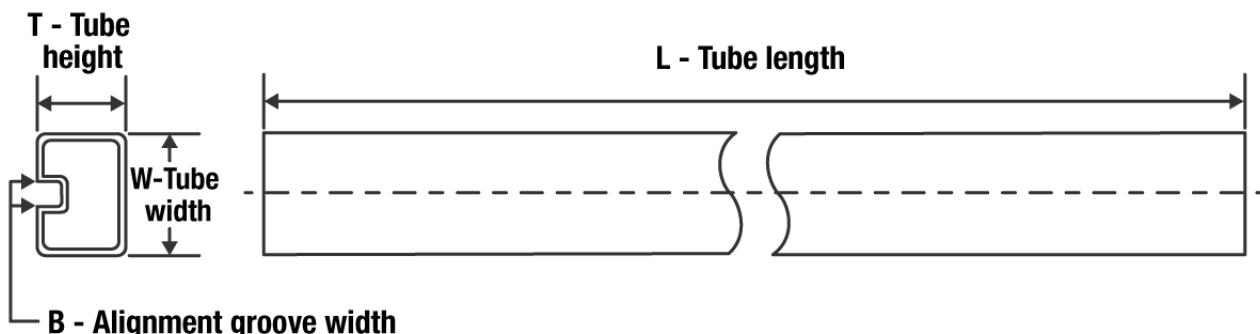
*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC2652AI-8DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC2652C-8DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC2652I-8DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC2652AI-8DR	SOIC	D	8	2500	340.5	336.1	25.0
TLC2652C-8DR	SOIC	D	8	2500	340.5	336.1	25.0
TLC2652I-8DR	SOIC	D	8	2500	340.5	336.1	25.0

TUBE


*All dimensions are nominal

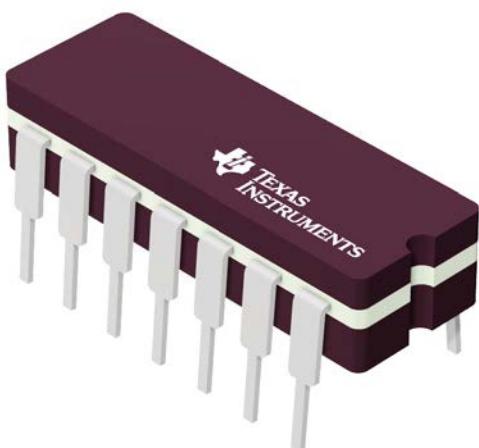
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μ m)	B (mm)
TLC2652AC-14D	D	SOIC	14	50	505.46	6.76	3810	4
TLC2652AC-8D	D	SOIC	8	75	507	8	3940	4.32
TLC2652AC-8D	D	SOIC	8	75	505.46	6.76	3810	4
TLC2652ACN	N	PDIP	14	25	506	13.97	11230	4.32
TLC2652ACP	P	PDIP	8	50	506	13.97	11230	4.32
TLC2652AI-14D	D	SOIC	14	50	505.46	6.76	3810	4
TLC2652AI-8D	D	SOIC	8	75	507	8	3940	4.32
TLC2652AI-8D	D	SOIC	8	75	505.46	6.76	3810	4
TLC2652AIN	N	PDIP	14	25	506	13.97	11230	4.32
TLC2652AIP	P	PDIP	8	50	506	13.97	11230	4.32
TLC2652C-8D	D	SOIC	8	75	507	8	3940	4.32
TLC2652C-8D	D	SOIC	8	75	505.46	6.76	3810	4
TLC2652CN	N	PDIP	14	25	506	13.97	11230	4.32
TLC2652CP	P	PDIP	8	50	506	13.97	11230	4.32
TLC2652I-8D	D	SOIC	8	75	507	8	3940	4.32
TLC2652I-8D	D	SOIC	8	75	505.46	6.76	3810	4
TLC2652Q-8D	D	SOIC	8	75	505.46	6.76	3810	4
TLC2652Q-8DG4	D	SOIC	8	75	505.46	6.76	3810	4

GENERIC PACKAGE VIEW

J 14

CDIP - 5.08 mm max height

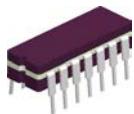
CERAMIC DUAL IN LINE PACKAGE



Images above are just a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.

4040083-5/G

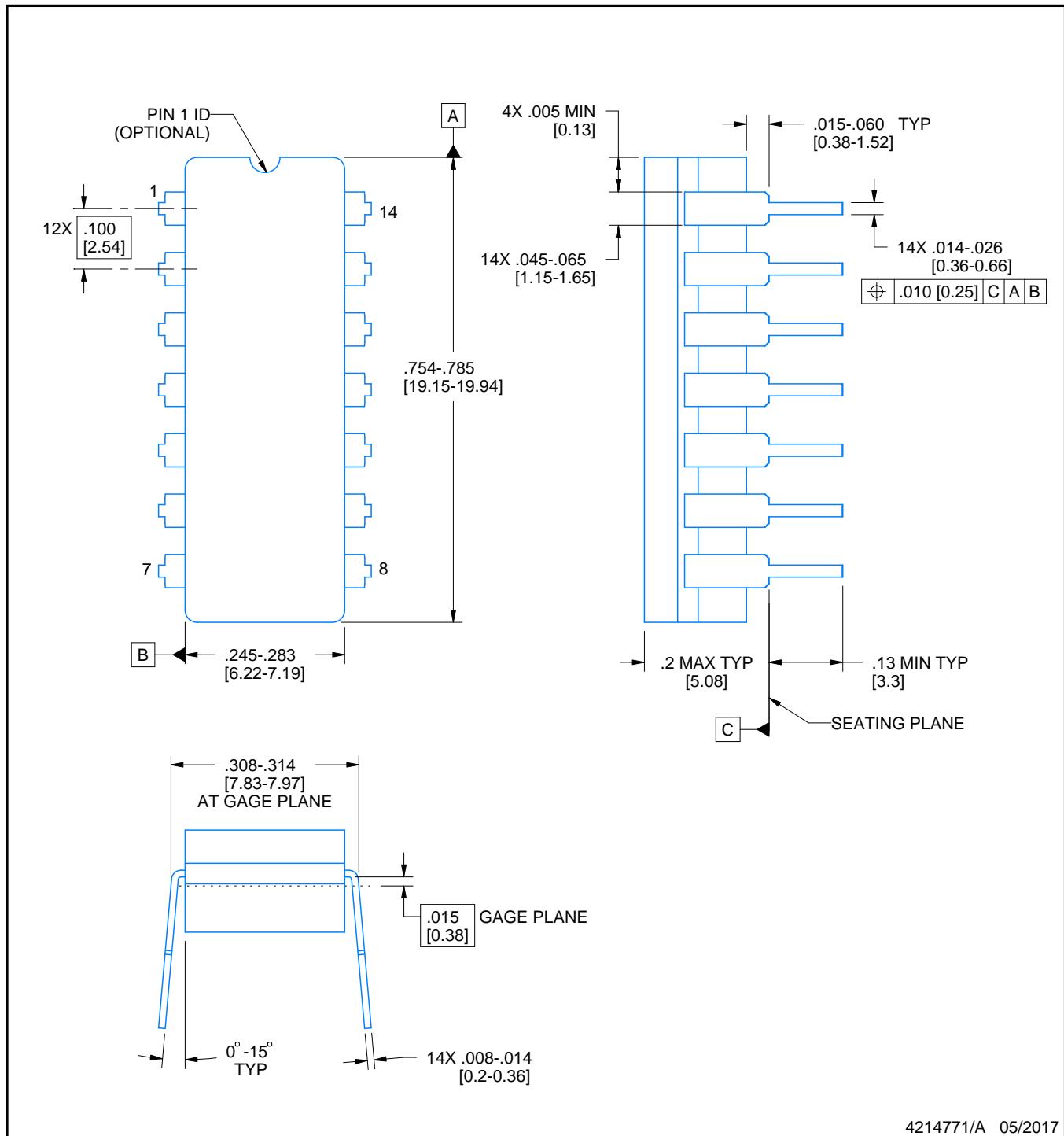
J0014A



PACKAGE OUTLINE

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



4214771/A 05/2017

NOTES:

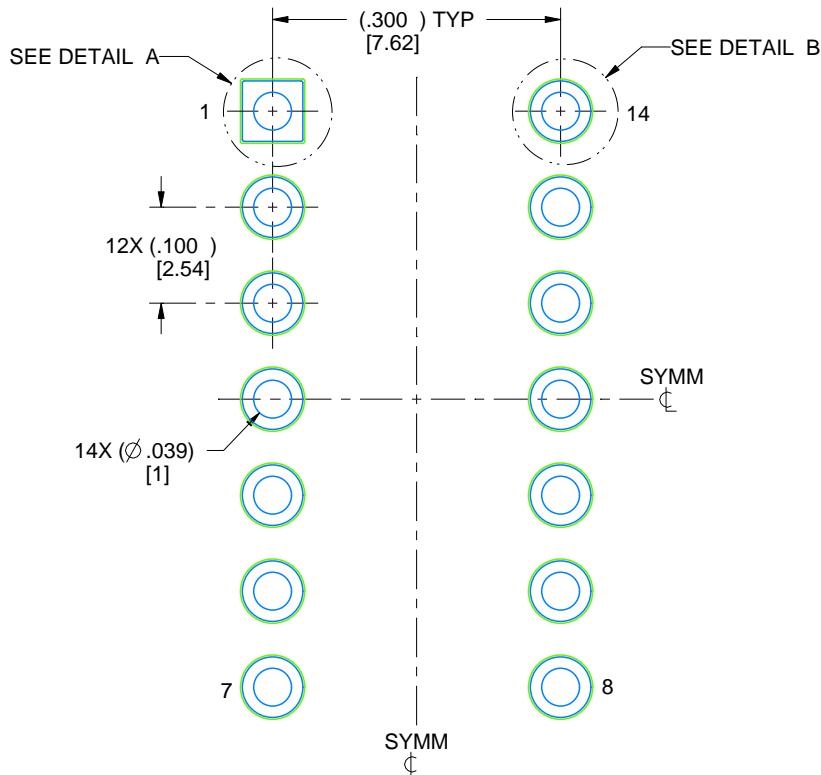
1. All controlling linear dimensions are in inches. Dimensions in brackets are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This package is hermetically sealed with a ceramic lid using glass frit.
4. Index point is provided on cap for terminal identification only and on press ceramic glass frit seal only.
5. Falls within MIL-STD-1835 and GDIP1-T14.

EXAMPLE BOARD LAYOUT

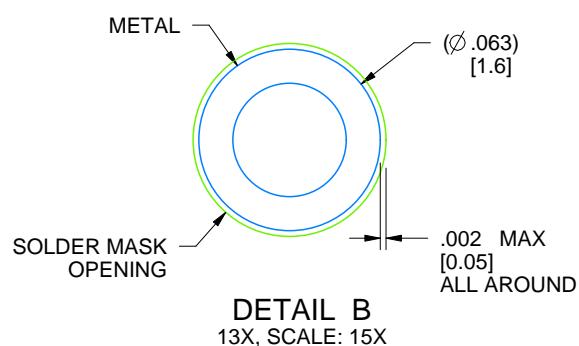
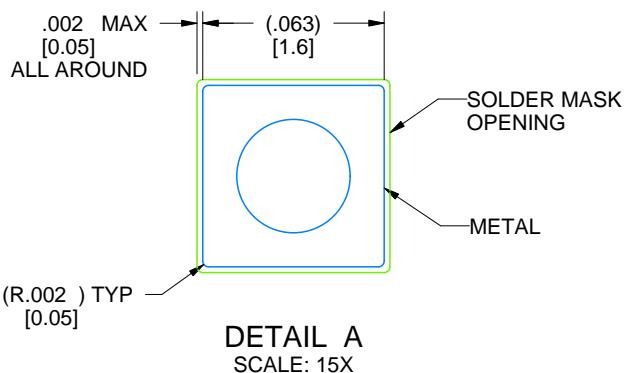
J0014A

CDIP - 5.08 mm max height

CERAMIC DUAL IN LINE PACKAGE



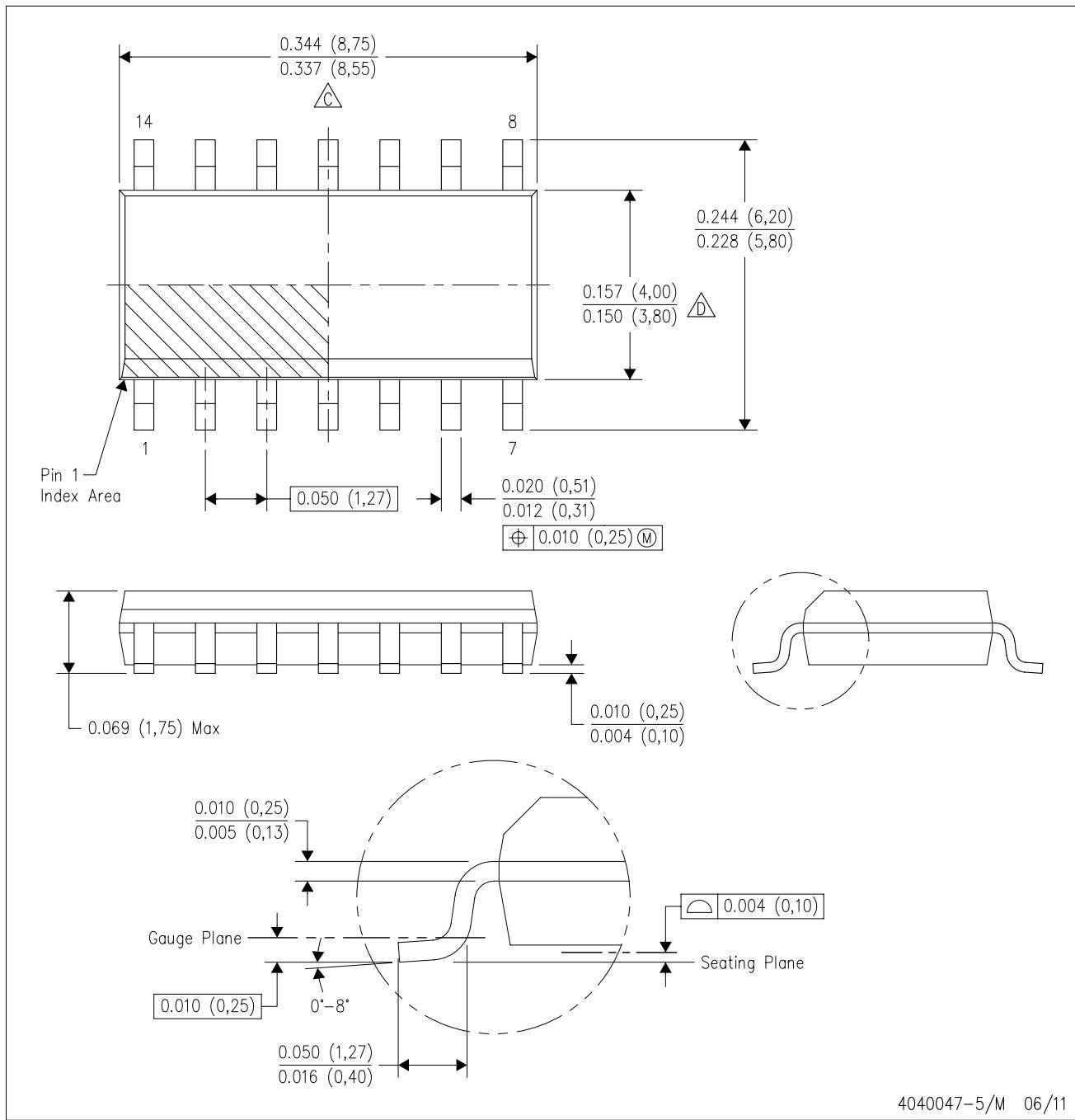
LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE: 5X



4214771/A 05/2017

D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.

D Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.

E. Reference JEDEC MS-012 variation AB.

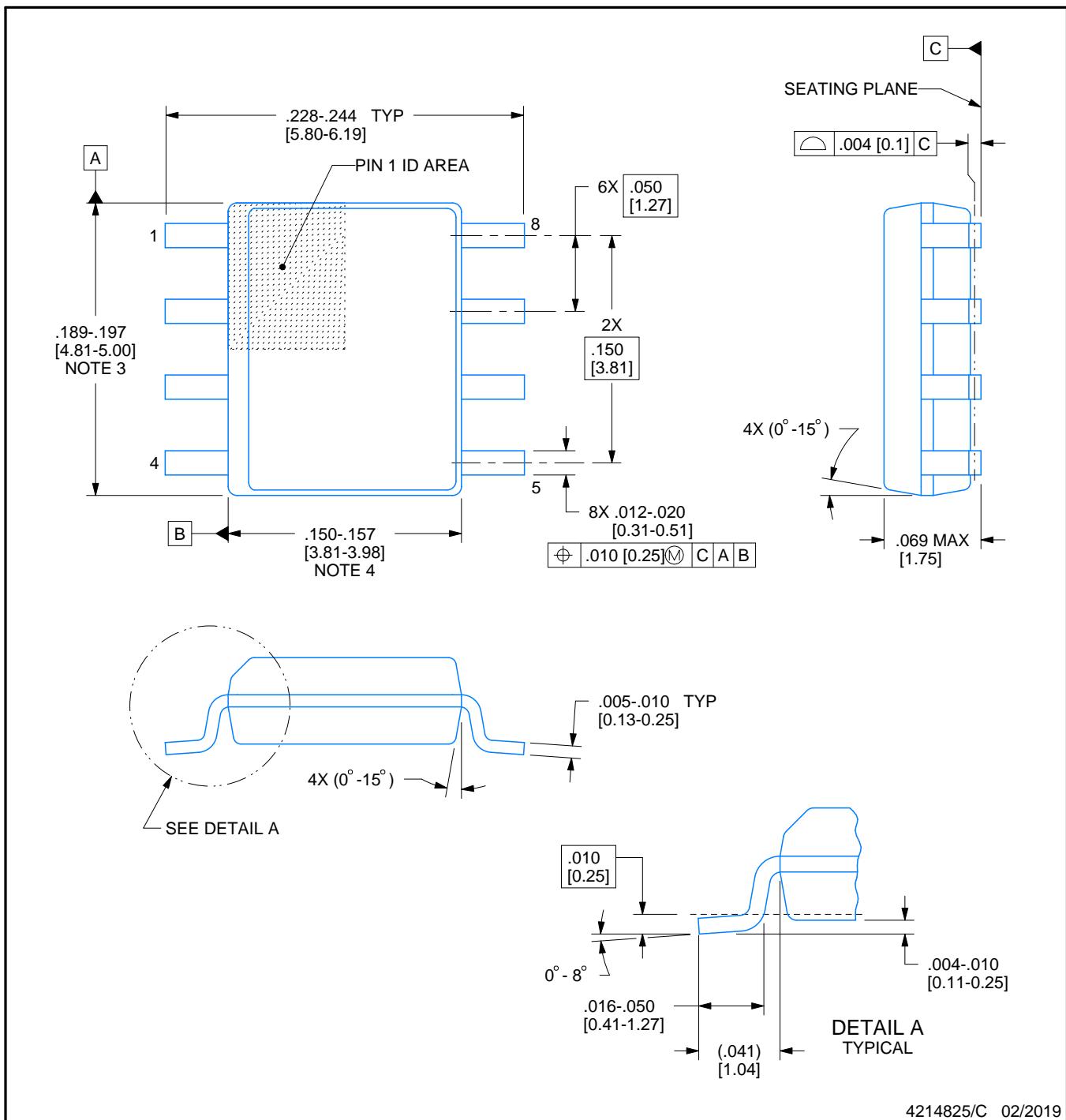
D0008A



PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES:

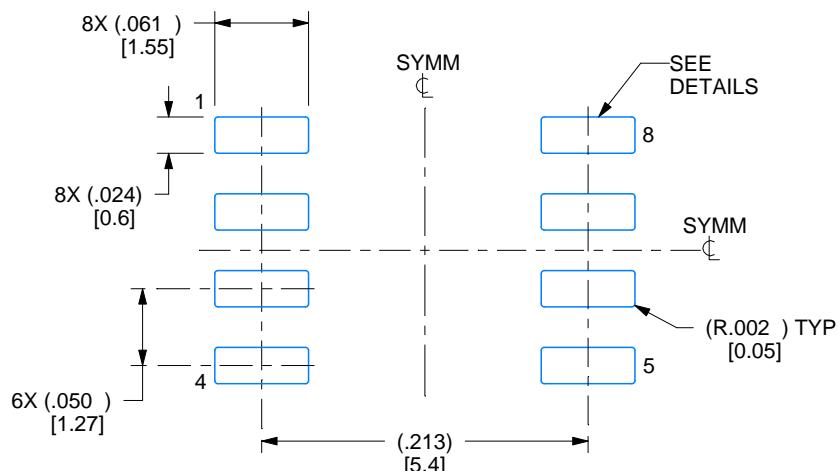
- Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- This drawing is subject to change without notice.
- This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- This dimension does not include interlead flash.
- Reference JEDEC registration MS-012, variation AA.

EXAMPLE BOARD LAYOUT

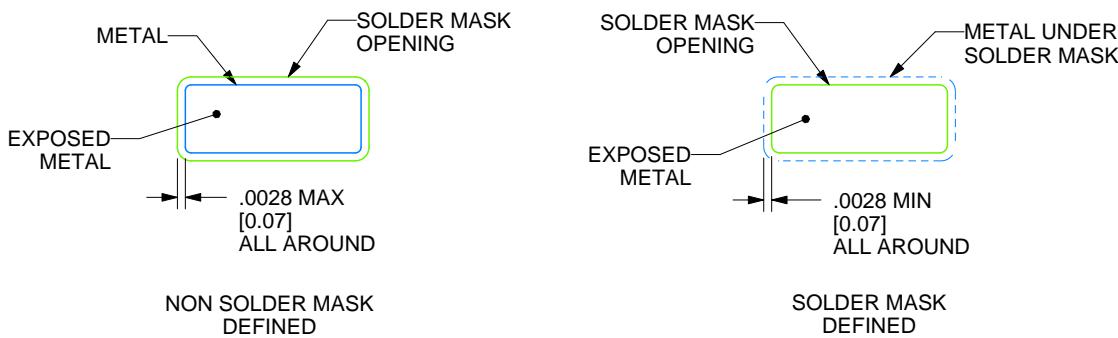
D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

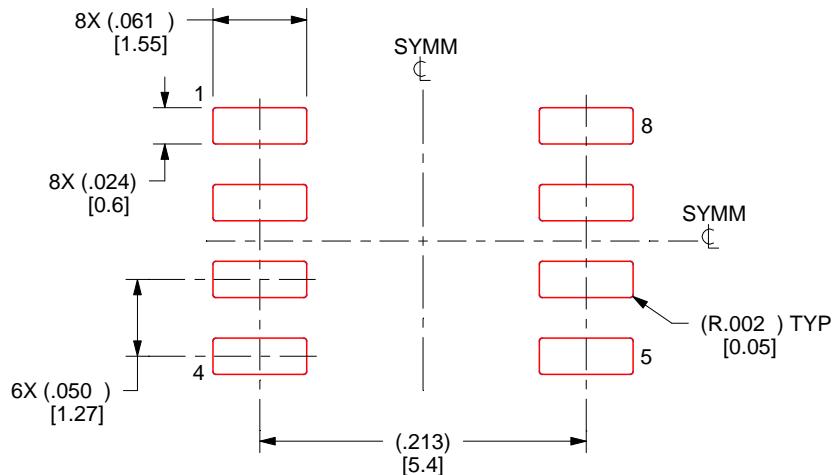
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON .005 INCH [0.125 MM] THICK STENCIL
SCALE:8X

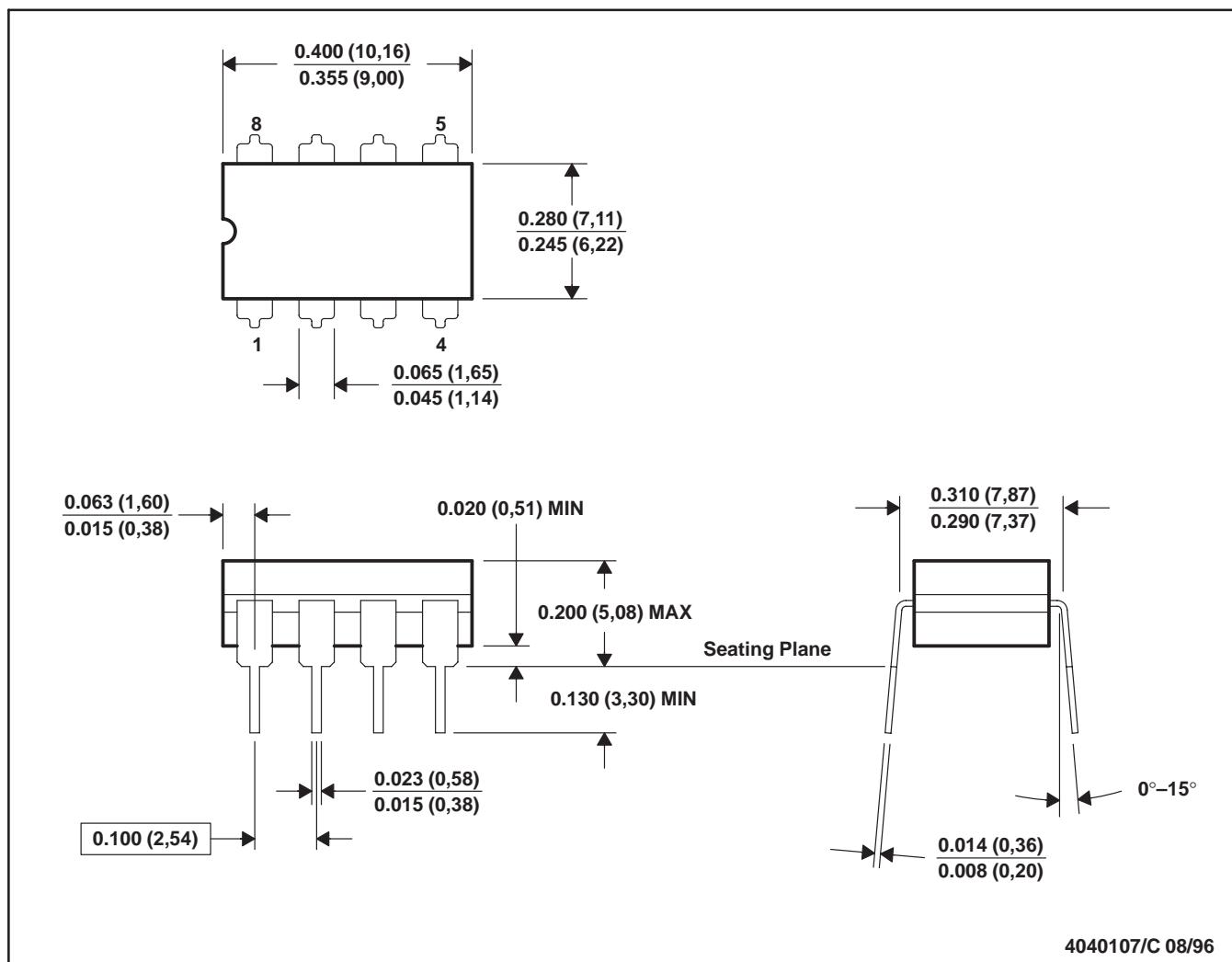
4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

JG (R-GDIP-T8)

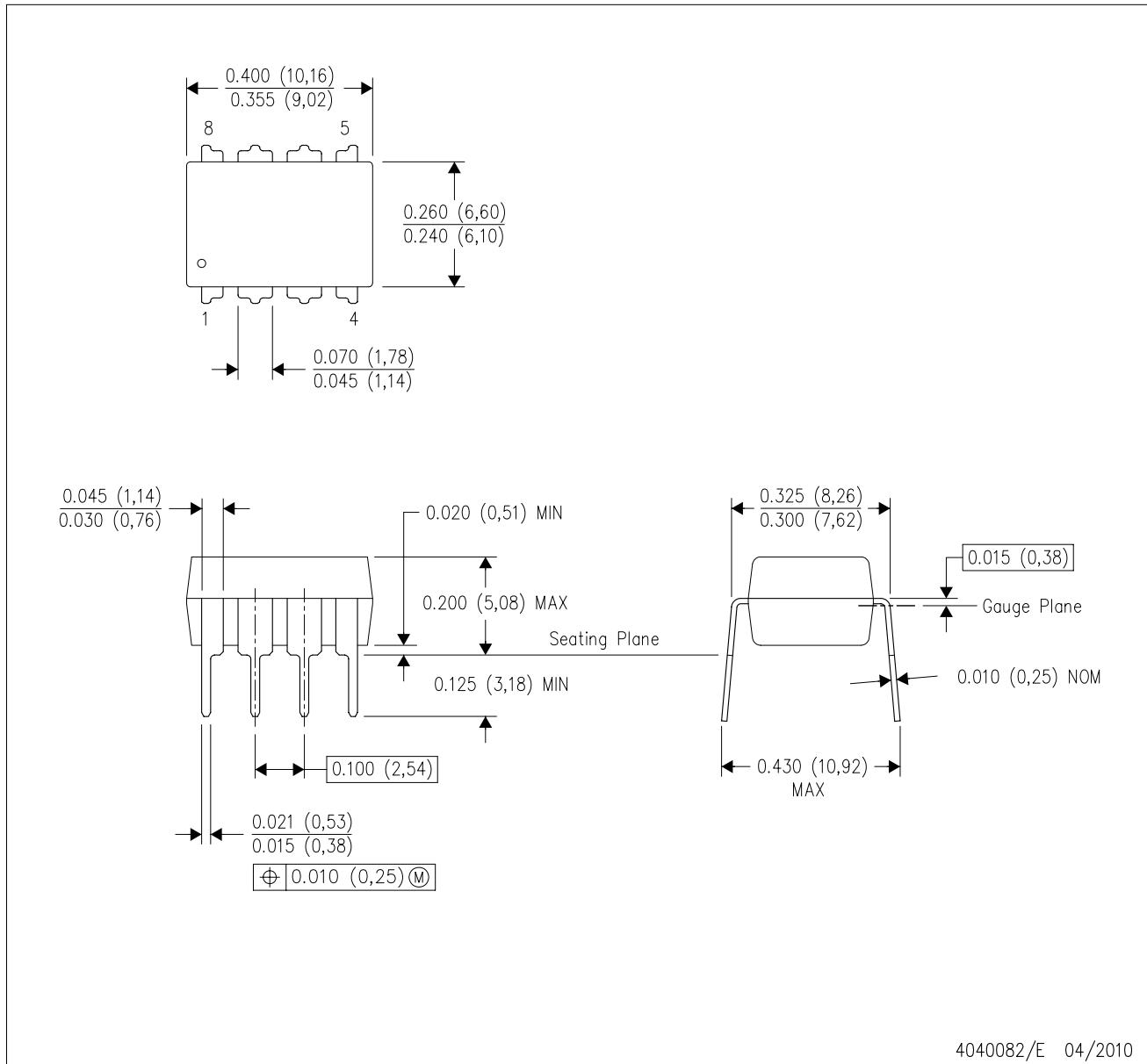
CERAMIC DUAL-IN-LINE



MECHANICAL DATA

P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



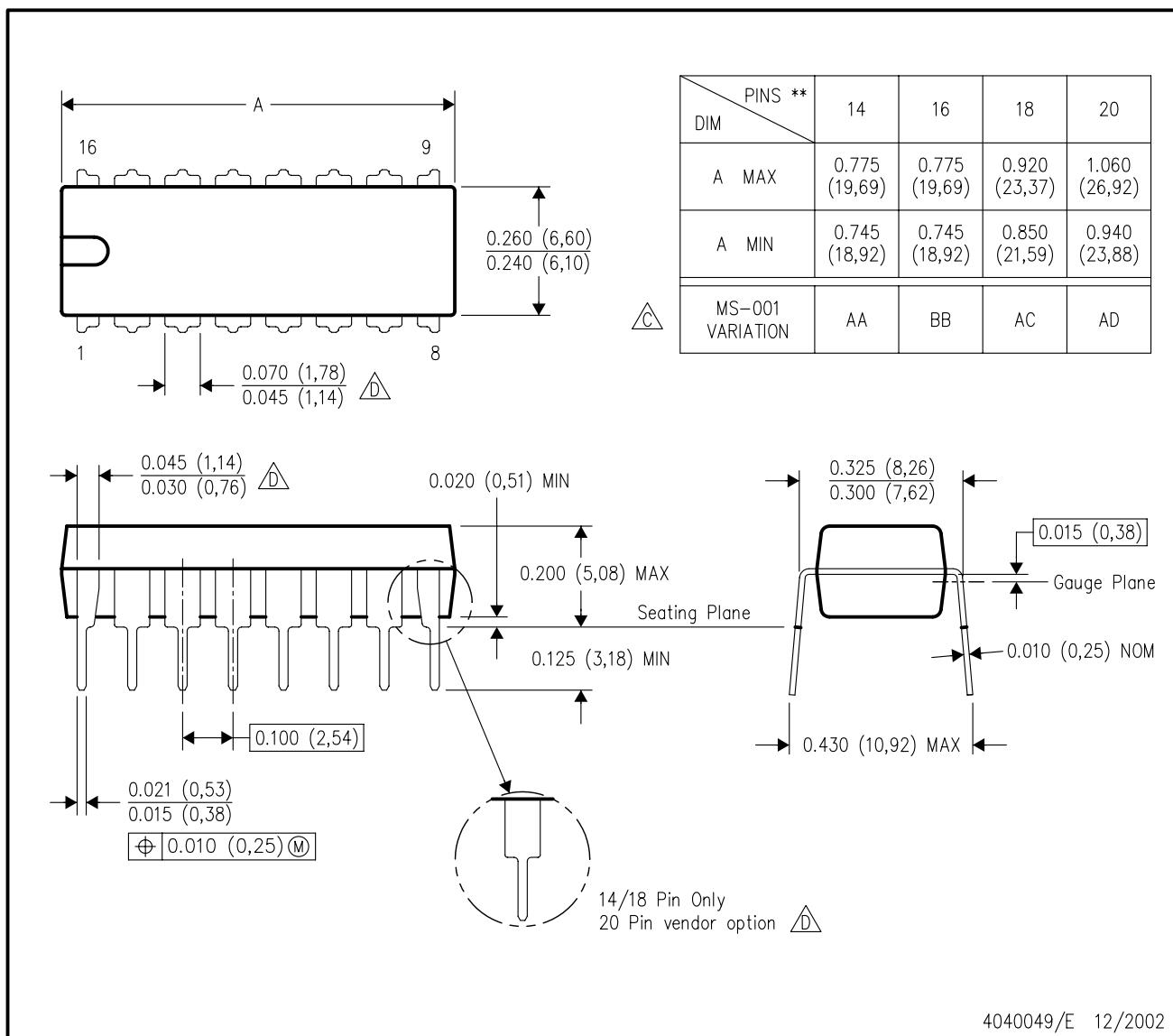
4040082/E 04/2010

- NOTES:
- All linear dimensions are in inches (millimeters).
 - This drawing is subject to change without notice.
 - Falls within JEDEC MS-001 variation BA.

N (R-PDIP-T**)

16 PINS SHOWN

PLASTIC DUAL-IN-LINE PACKAGE



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